

Search Notes

Application/Control No.

10/615,153

Examiner

Michael Peffley

Applicant(s)/Patent under
Reexamination

OHYAMA ET AL.

Art Unit

3739

SEARCHED

Class	Subclass	Date	Examiner
update	previous	1/24/2006	MP

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR